

AUTOMOTIVE GRADE

AUIRFS8408 AUIRFSL8408

Features

- Advanced Process Technology
- New Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- · Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

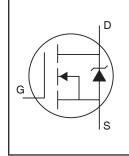
Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this product an extremely efficient and reliable device for use in Automotive and wide variety of other applications.

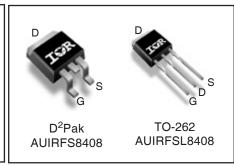
Applications

- Electric Power Steering (EPS)
- Battery Switch
- · Start/Stop Micro Hybrid
- Heavy Loads
- SMPS

HEXFET® Power MOSFET

V _{DSS}	40V
R _{DS(on)} typ.	1.3m Ω
max.	1.6m Ω
I _{D (Silicon Limited)}	317A ①
I _{D (Package Limited)}	195A





G	D	S
Gate	Drain	Source

Ordering Information

Base part number	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRFSL8408	TO-262	Tube	50	AUIRFSL8408
AUIRFS8408	D ² Pak	Tube	50	AUIRFS8408
		Tape and Reel Left	800	AUIRFS8408TRL
		Tape and Reel Right	800	AUIRFS8408TRR

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	317①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	224①	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	195	Α
Ірм	Pulsed Drain Current ②	1270®	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	294	W
	Linear Derating Factor	1.96	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
$T_{\rm J}$	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Avalanche Characteristics

E _{AS (Thermally limited)}	Single Pulse Avalanche Energy ③	490	1
E _{AS (tested)}	Single Pulse Avalanche Energy Tested Value ③	800	mJ
I _{AR}	Avalanche Current ②	See Fig. 14, 15, 24a, 24b	Α
FAB	Repetitive Avalanche Energy ②		m,J

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		0.51	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ®		40	

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/



Static @ T ₁ = 25°C (unless otherwise spe
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Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.032		V/°C	Reference to 25°C, I _D = 5mA ²
R _{DS(on)}	Static Drain-to-Source On-Resistance		1.3	1.6	mΩ	$V_{GS} = 10V, I_D = 100A$
$V_{GS(th)}$	Gate Threshold Voltage	2.2	3.0	3.9	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
I _{DSS}	Drain-to-Source Leakage Current			1.0		$V_{DS} = 40V$, $V_{GS} = 0V$
				150	μA	$V_{DS} = 40V, V_{GS} = 0V, T_J = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	- A	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$
R _G	Internal Gate Resistance		2.1		Ω	

Dynamic @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	211				$V_{DS} = 10V, I_D = 100A$
\overline{Q}_g	Total Gate Charge		216	324		I _D = 100A
Qgs	Gate-to-Source Charge		51			V _{DS} =20V
Q _{gd}	Gate-to-Drain ("Miller") Charge		77		nC	V _{GS} = 10V ^⑤
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		139			$I_D = 100A$, $V_{DS} = 0V$, $V_{GS} = 10V$
$t_{d(on)}$	Turn-On Delay Time		29			$V_{DD} = 26V$
t _r	Rise Time		202			$I_{D} = 100A$
t _{d(off)}	Turn-Off Delay Time		108		ns	$R_G = 2.4\Omega$
t _f	Fall Time		119	_		V _{GS} = 10V ⑤
C _{iss}	Input Capacitance		10820			$V_{GS} = 0V$
Coss	Output Capacitance		1540			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		1140		pF	f = 1.0 MHz, See Fig. 5
Coss eff. (ER)	Effective Output Capacitance (Energy Related)		1880			$V_{GS} = 0V$, $V_{DS} = 0V$ to $32V$ $©$ See Fig. 11
Coss eff. (TR)	Effective Output Capacitance (Time Related)		2208	_		$V_{GS} = 0V$, $V_{DS} = 0V$ to 32V \bigcirc

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current			317 ^①		MOSFET symbol
	(Body Diode)			3170	_	showing the
I _{SM}	Pulsed Source Current			1270®	A	integral reverse
	(Body Diode) ①			1270		p-n junction diode.
V_{SD}	Diode Forward Voltage		0.9	1.3	V	$T_J = 25^{\circ}C$, $I_S = 100A$, $V_{GS} = 0V$ \odot
dv/dt	Peak Diode Recovery 4		5.0		V/ns	$T_J = 175^{\circ}C$, $I_S = 100A$, $V_{DS} = 40V$
t _{rr}	Reverse Recovery Time		38		no	$T_J = 25^{\circ}C$ $V_R = 34V$,
			37		ns	$T_{\rm J} = 125^{\circ} {\rm C}$ $I_{\rm F} = 100 {\rm A}$
Q _{rr}	Reverse Recovery Charge		50			$T_J = 25^{\circ}C$ di/dt = 100A/ μ s
			50	_	nC	$T_J = 125$ °C
I _{RRM}	Reverse Recovery Current		1.9		Α	T _J = 25°C

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 195A by source bonding technology. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by T_{Jmax} , starting T_J = 25°C, L = 0.099mH, R_G = 50 Ω , I_{AS} = 100A, V_{GS} =10V. Part not recommended for use above this value.
- $\textcircled{4} \ I_{SD} \leq 100 A, \ di/dt \leq 1307 A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175 ^{\circ} C.$

- ⑤ Pulse width $\leq 400\mu s$; duty cycle $\leq 2\%$.
- $\ \ \, \ \, \ \,$ $\ \ \, \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \$ $\$ $\ \$ $\ \$ $\ \$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\ \$ $\$ $\$ $\$ $\$ $\$ $\ \$ $\$
- $\colongraph{ \odot}$ C coss eff. (ER) is a fixed capacitance that gives the same energy as C coss while VDS is rising from 0 to 80% VDSS.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- $\ \ \,$ $\ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$
- ® Pulse drain current is limited by source bonding technology.

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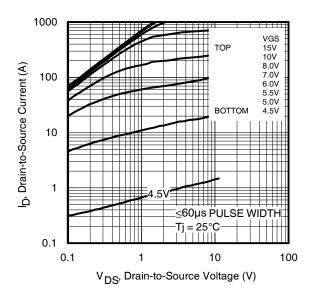


Fig 1. Typical Output Characteristics

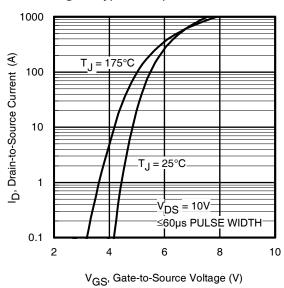


Fig 3. Typical Transfer Characteristics

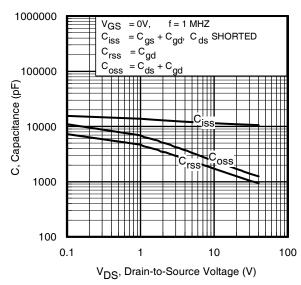


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

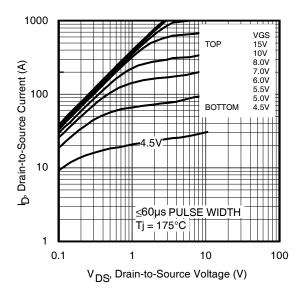


Fig 2. Typical Output Characteristics

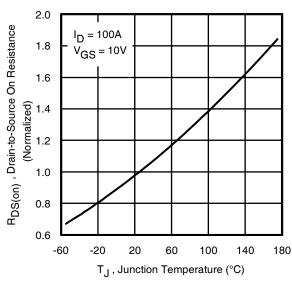


Fig 4. Normalized On-Resistance vs. Temperature

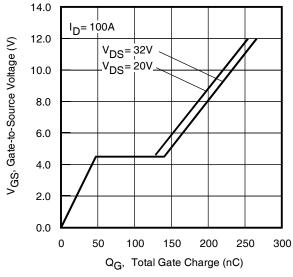


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



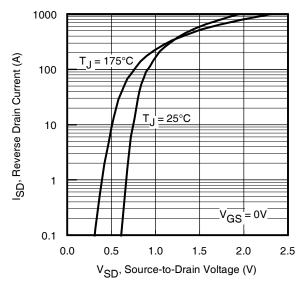


Fig 7. Typical Source-Drain Diode Forward Voltage

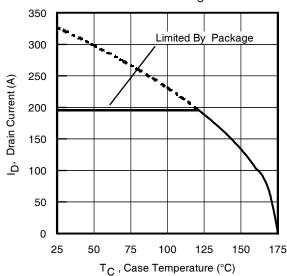


Fig 9. Maximum Drain Current vs. Case Temperature

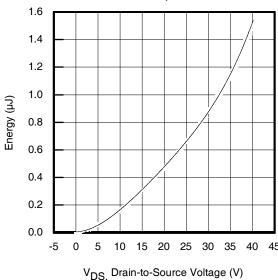


Fig 11. Typical C_{OSS} Stored Energy

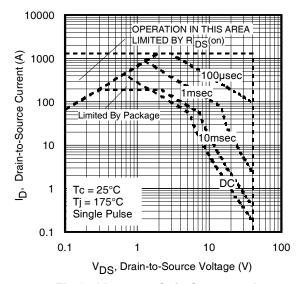


Fig 8. Maximum Safe Operating Area

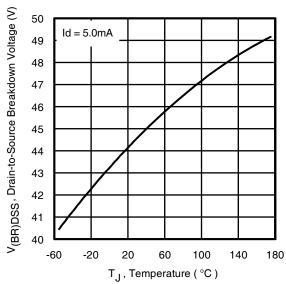


Fig 10. Drain-to-Source Breakdown Voltage

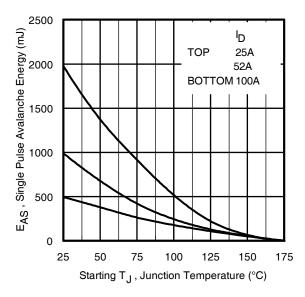


Fig 12. Maximum Avalanche Energy vs. DrainCurrent

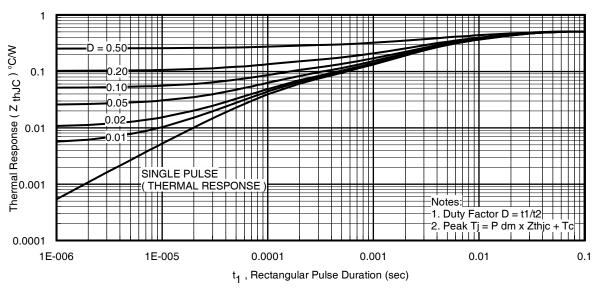


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

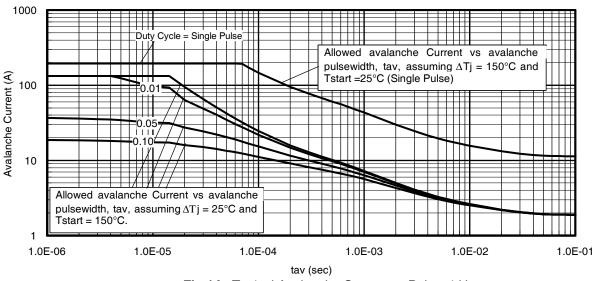


Fig 14. Typical Avalanche Current vs. Pulsewidth

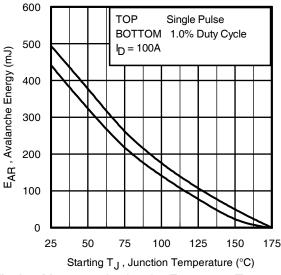


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 14, 15 (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 24a, 24b.
- 4. P_{D (ave)} = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
 - t_{av} = Average time in avalanche.
 - D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} = 1/2 \; (\; 1.3 \cdot BV \cdot I_{aV}) = \triangle T / \; Z_{thJC} \\ I_{av} = 2\triangle T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} = P_{D \; (ave)} \cdot t_{av} \end{split}$$



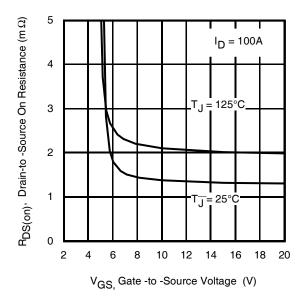


Fig 16. On-Resistance vs. Gate Voltage

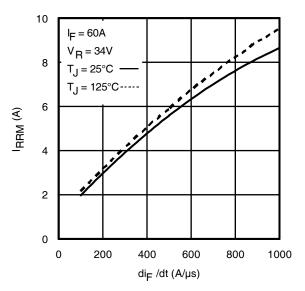


Fig. 18 - Typical Recovery Current vs. dif/dt

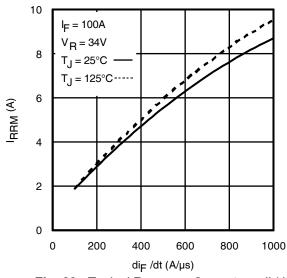


Fig. 20 - Typical Recovery Current vs. dif/dt

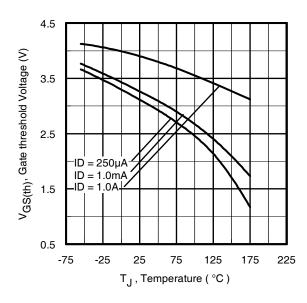


Fig 17. Threshold Voltage vs. Temperature

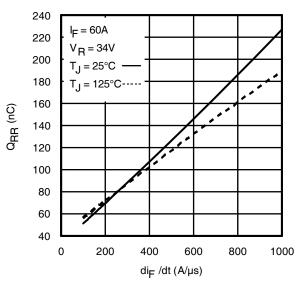


Fig. 19 - Typical Stored Charge vs. dif/dt

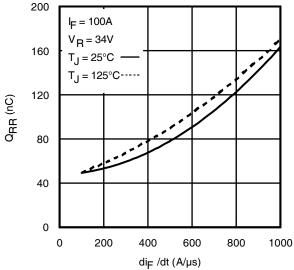


Fig. 21 - Typical Stored Charge vs. di_f/dt



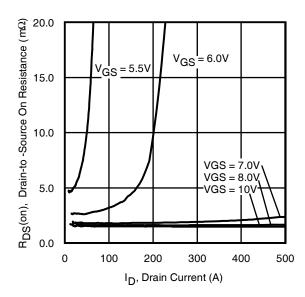


Fig 22. Typical On-Resistance vs. Drain Current



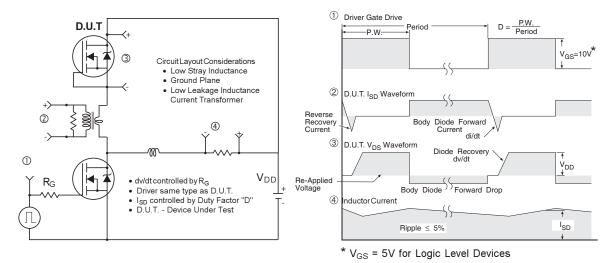


Fig 23. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

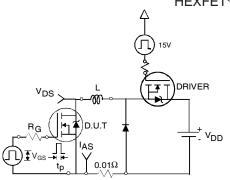


Fig 24a. Unclamped Inductive Test Circuit

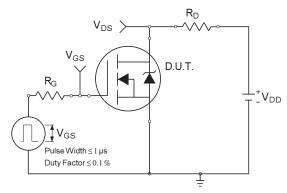


Fig 25a. Switching Time Test Circuit

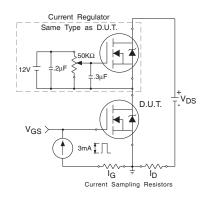


Fig 26a. Gate Charge Test Circuit

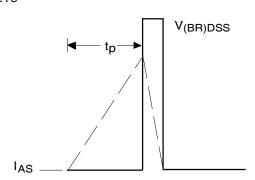


Fig 24b. Unclamped Inductive Waveforms

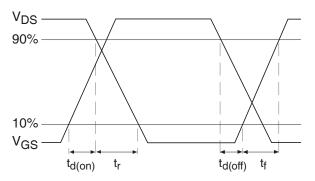


Fig 25b. Switching Time Waveforms

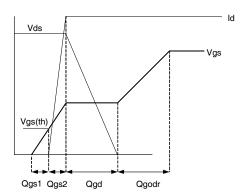
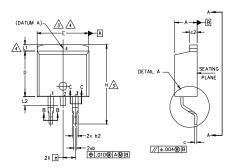


Fig 26b. Gate Charge Waveform

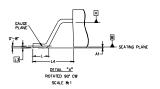
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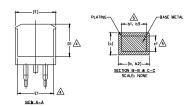


D²Pak Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3\Dimension D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

A. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7, CONTROLLING DIMENSION; INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S		DIMENSIONS						
М В О	MILLIM	ETERS	INC	HES	O T E S			
L	MIN.	MAX.	MIN.	MAX.	S			
Α	4.06	4.83	.160	.190				
A1	0.00	0.254	.000	.010				
b	0.51	0.99	.020	.039				
ь1	0.51	0.89	.020	.035	5			
b2	1,14	1.78	.045	.070				
ь3	1,14	1.73	.045	.068	5			
С	0.38	0.74	.015	.029				
c1	0.38	0.58	.015	.023	5			
c2	1,14	1.65	.045	.065				
D	8.38	9.65	.330	.380	3			
D1	6,86	-	.270		4			
Ε	9.65	10.67	.380	.420	3,4			
E1	6.22	-	.245		4			
е	2.54	BSC	.100	BSC]			
Н	14.61	15.88	.575	.625				
L	1.78	2.79	.070	.110				
L1	-	1.65	-	.066	4			
L2	1.27	1.78	-	.070				
L3	0.25	BSC	.010	BSC	1			
L4	4.78	5.28	.188	.208	1			

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2. 4.- DRAIN 3.- SOURCE

IGBTs. CoPACK

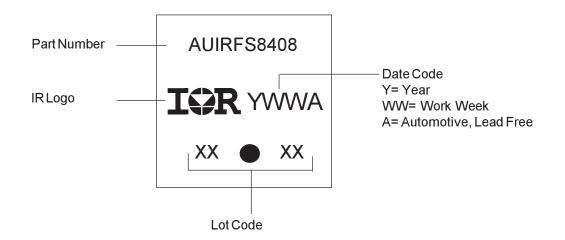
1.- GATE
2, 4.- COLLECTOR
3.- EMITTER

DIODES

1.- ANODE *
2, 4.- CATHODE
3.- ANODE

* PART DEPENDENT.

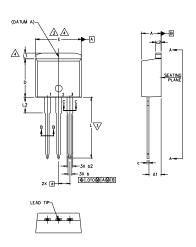
D²Pak Part Marking Information

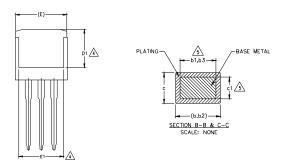


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



TO-262 Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

S Y M B			N C		
B	MILLIM	ETERS	INC	HES	NO T E S
L	MIN.	MAX.	MIN.	MAX.	E S
Α	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
ь	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	5
b2	1,14	1,78	.045	.070	
b3	1,14	1,73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1,14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270	-	4
Ε	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
e	2.54	BSC	.100 BSC		
L	13.46	14,10	.530	.555	
L1	-	1.65	-	.065	4
L2	3.56	3.71	.140	.146	

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE

2.- DRAIN 3.- SOURCE

4.- DRAIN

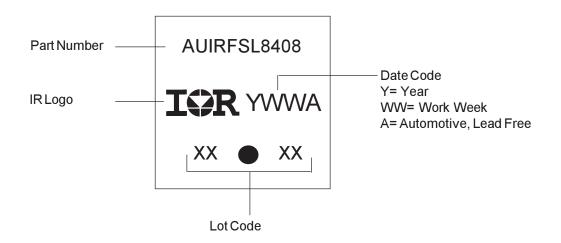
IGBTs, CoPACK

1.- GATE

2.- COLLECTOR 3.- EMITTER

4.- COLLECTOR

TO-262 Part Marking Information

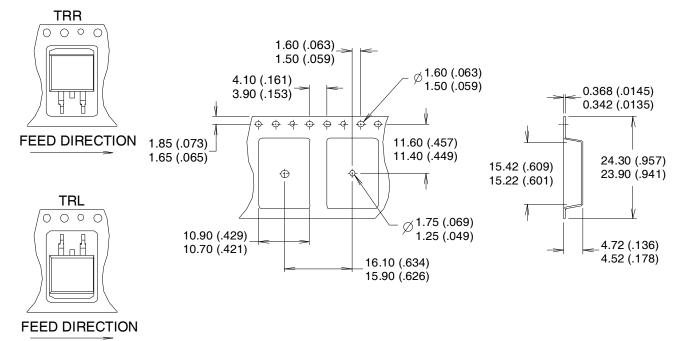


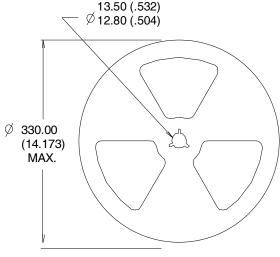
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

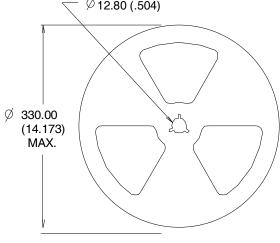


D²Pak (TO-263AB) Tape & Reel Information

Dimensions are shown in millimeters (inches)

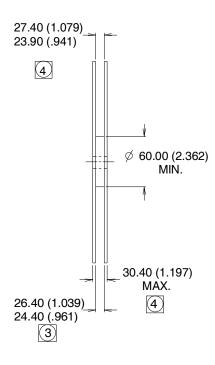






NOTES:

- 1. COMFORMS TO EIA-418.
- CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION MEASURED @ HUB.
- 4 INCLUDES FLANGE DISTORTION @ OUTER EDGE.





Qualification Information[†]

Qualification Level			Automotive (per AEC-Q101)	
			part number(s) passed Automotive qualification. IR's Industrial qualification level is granted by extension of the higher	
Moisture Sensitivity Level		3L-D ² PAK	MSL1	
		3L-TO-262-PAK	N/A	
ESD	Machine Model	Class M4 (+/- 600) ^{††}		
		AEC-Q101-002		
	Human Body Model	Class H3A (+/- 6000) ^{††}		
		AEC-Q101-001		
	Charged Device Model	Class C5 (+/- 2000) ^{††}		
		AEC-Q101-005		
RoHS Compliant			Yes	

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/
- †† Highest passing voltage.

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For technical support, please contact IR's Technical Assistance Center

http://www.irf.com/technical-info/

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